

Please type a plus sign (+) inside this box → ☐

PTO/SB/08B (08-00)

Approved for use through 10/31/2002. OMB 0651-0031


U.S. Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Complete if Known	
				Application Number	Not Yet Assigned
				Filing Date	May 25, 2001
				First Named Inventor	Hajime KIMURA
				Group Art Unit	Not Yet Assigned
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	756-2317

1000 U.S. P.T.O.
09/864280
05/25/01

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
WJ		"Revised MOS Solid Image Pickup Element - Spreading Its Applications with Arms of Low Power Consumption", Nikkei Electronics, July 14, 1997, pp. 119-124	
WJ		"CMOS Image Sensors: Electronic Camera On a Chip", IEDM 95, pp.17-25	
WJ		"CMOS Image Sensors - Recent Advances and Device Scaling Considerations", IDEM 97, pp. 201-204	
WJ		"Survey of Development of CMOS Camera", JIEC Seminar, February 20, 1998, pp. 1-11	
WJ		"CCD for Digital Camera Steered from Exclusive Devotion to Pixel Number to Improvement in Sensitivity", Nikkei Electronics, December 14, 1998, pp. 47-52	
WJ		"Appearance of CCD Directed to Personal Computer Camera", Nikkei Electronics, April 24, 1995, pp. 159-168	
WJ		"Solid Image Pickup Element Cameras Having Been Reported These 18 Years", Nikkei Electronics, September 14, 1992, pp. 261-291	
WJ		"X-ray Detectors based on Amorphous Silicon Active MATRIX", Euro Display 99, pp. 203-207	
WJ		"Amorphous Silicon TFT X-ray Image Sensors", IEDM 98, pp. 21-24	
WJ		"Real-time Imaging Flat Panel X-ray Detector", AM-LCD'99, pp. 45-48	

Examiner Signature		Date Considered	8/23/04
--------------------	---	-----------------	---------

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² Applicant is to place a check mark here if English language Translation is attached.

Burden Hour Statement: This form is estimated to take 2.0 hours to complete. Time will vary depending upon the needs of the individual case. Any comments on the amount of time you are required to complete this form should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Assistant Commissioner for Patents, Washington, DC 20231.